

## P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)			
- 30	$0.0032$ at $V_{GS} = -10 \text{ V}$	- 100	78 nC			
	0.0050 at V <sub>GS</sub> = - 4.5 V	- 80	70110			

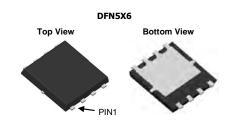
#### **FEATURES**

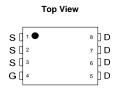
- Halogen-free
- TrenchFET<sup>®</sup> Power MOSFET
- 100 % R<sub>g</sub> Tested

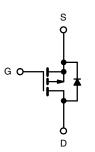


#### **APPLICATIONS**

- Notebook
  - Load Switch







P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	T <sub>A</sub> = 25 °C, unle	ss otherwise no	ted	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	$V_{DS}$	- 30	V	
Gate-Source Voltage	V <sub>GS</sub>	± 20	<b>V</b>	
	T <sub>C</sub> = 25 °C		- 100	
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	I <sub>D</sub>	- 75	
commission Draw Carron (1, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1	T <sub>A</sub> = 25 °C	. <sub>U</sub>	- 31.6 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C		- 25.3 <sup>b, c</sup>	A
Pulsed Drain Current		I <sub>DM</sub>	- 300	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>S</sub>	- 60 <sup>a</sup>	
Continuous Source Diam Blode Guilent	T <sub>A</sub> = 25 °C	'8	- 5.6 <sup>b, c</sup>	
Single Pulse Avalanche Current		I <sub>AS</sub>	- 40	
Single Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	80	mJ
	T <sub>C</sub> = 25 °C		104	
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	66.6	w
Maximum rower bissipation	T <sub>A</sub> = 25 °C	, p	6.25 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C		4.0 <sup>b, c</sup>	
Operating Junction and Storage Temperature Ra	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature		260		

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 10 s	R <sub>thJA</sub>	15	20	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	0.9	1.2	O/VV		

#### Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. The DFN5x6 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 54 °C/W.

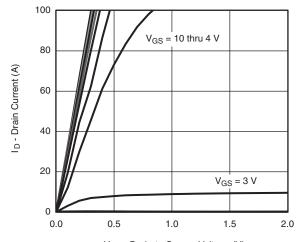


<b>SPECIFICATIONS</b> T <sub>J</sub> = 25 °C, unless otherwise noted								
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit		
Static								
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	- 30			٧		
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = - 250 μA		- 31		mV/°C		
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	10 = - 250 μΑ		6.5				
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = -250 \mu A$	- 1.0		- 3.0	V		
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			- 1 - 10	μΑ		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> = - 5 V, V <sub>GS</sub> = - 10 V	- 30			Α		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = -10 \text{ V}, I_D = -20 \text{ A}$ $V_{GS} = -4.5 \text{ V}, I_D = -15 \text{ A}$		0.0032		Ω		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 20 A		95		S		
Dynamic <sup>b</sup>	013	50 , 5		1				
Input Capacitance	C <sub>iss</sub>			8650				
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		1215		pF		
Reverse Transfer Capacitance	C <sub>rss</sub>	7D5 10 1, 1 G5 0 1, 1 111112		1125				
Total Gate Charge	Q <sub>g</sub>	$V_{DS} = -15 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -20 \text{ A}$		167	250			
Oata Oarras Obarras	_	l , , , , , , , , , , , , , , , , , , ,		78	120	nC		
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -20 \text{ A}$		27				
Gate-Drain Charge	Q <sub>gd</sub>	( ( ) ( ) ( )		35				
Gate Resistance	R <sub>g</sub>	f = 1 MHz		1.7	40	Ω		
Turn-On Delay Time	t <sub>d(on)</sub>	V 45V B 45 0		25	40			
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 15 V, $R_L$ = 15 Ω $I_D \cong$ - 1.0 A, $V_{GEN}$ = - 10 V, $R_q$ = 1 Ω		15	30			
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = -1.0 \text{ A}, V_{GEN} = -10 \text{ V}, H_g = 1.52$		110	170			
Fall Time	t <sub>f</sub>			30	50	ns		
Turn-On Delay Time	t <sub>d(on)</sub>	V 45 V D 45 0		110	170	-		
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 15 V, $R_{L}$ = 15 Ω $I_{D} \cong$ - 1.0 A, $V_{GEN}$ = - 4.5 V, $R_{g}$ = 1 Ω		100	150			
Turn-Off Delay Time	t <sub>d(off)</sub>	ID = 1.0  A,  VGEN = 4.3  V,  Hg = 1.32		100	150			
Fall Time	t <sub>f</sub>			50	75			
Drain-Source Body Diode Characteristic		T <sub>C</sub> = 25 °C		T	60	1		
Continuous Source-Drain Diode Current	Is	1C = 25 C			60	Α		
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	I _ E A		0.74	100	.,		
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 5 A		- 0.74	- 1.1	V		
Body Diode Reverse Recovery Time	t <sub>rr</sub>			50	100	ns		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 3.5 A, dI/dt = 100 A/μs, T <sub>J</sub> = 25 °C		65	130	nC		
Reverse Recovery Fall Time	t <sub>a</sub>			26		ns		
Reverse Recovery Rise Time	t <sub>b</sub>			24				

- a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.

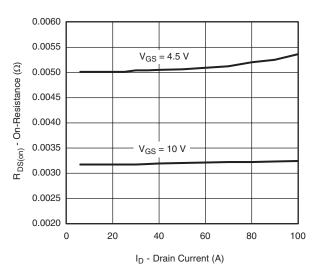
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



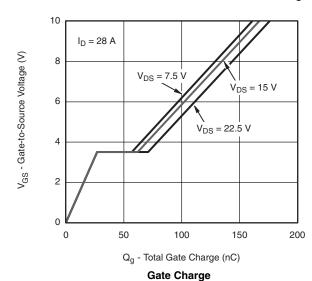


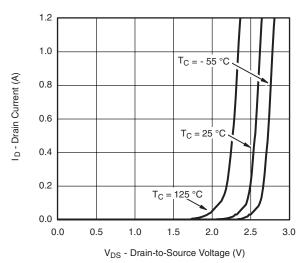
V<sub>DS</sub> - Drain-to-Source Voltage (V)

#### **Output Characteristics**

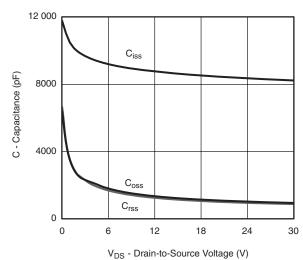


On-Resistance vs. Drain Current and Gate Voltage

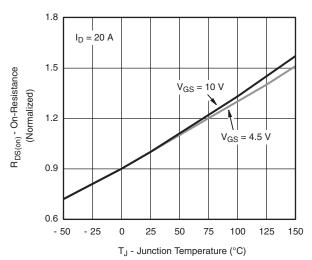




**Transfer Characteristics** 

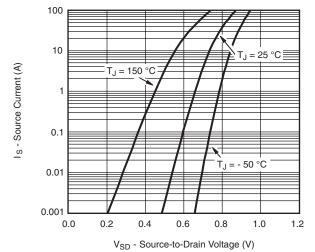


#### Capacitance

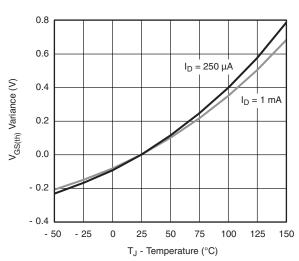


On-Resistance vs. Junction Temperature

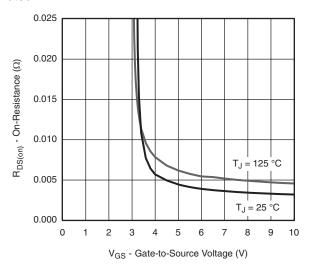




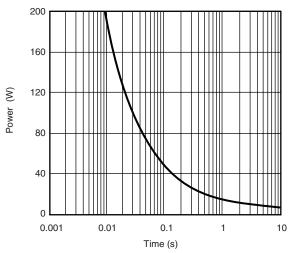
Source-Drain Diode Forward Voltage



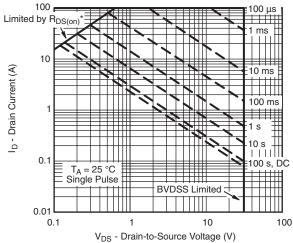
**Threshold Voltage** 



On-Resistance vs. Gate-to-Source Voltage



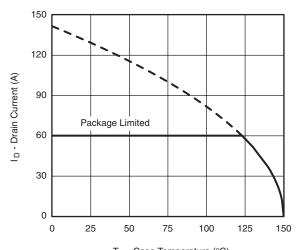
Single Pulse Power, Junction-to-Ambient



\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

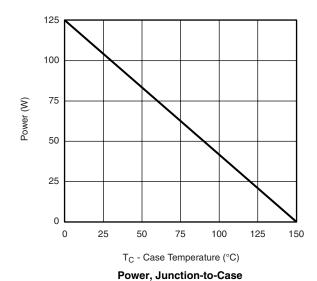
Safe Operating Area, Junction-to-Ambient

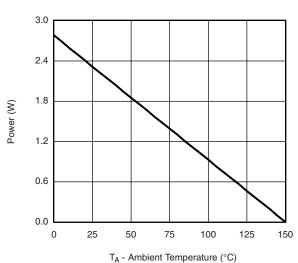




 $T_{\mbox{\scriptsize C}}$  - Case Temperature (°C)

#### **Current Derating\***

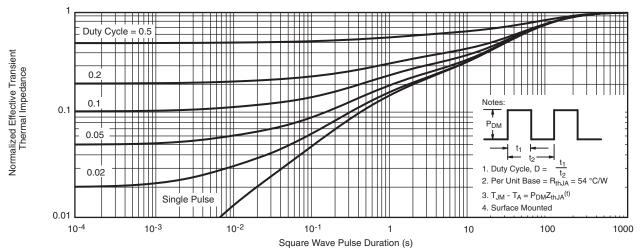




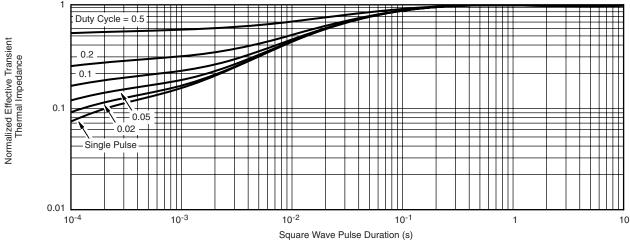
Power, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





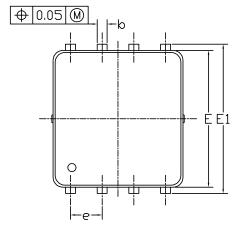
Normalized Thermal Transient Impedance, Junction-to-Ambient

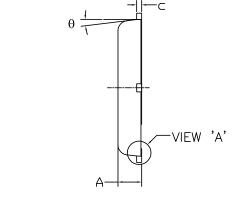


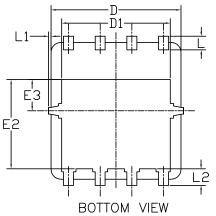
Normalized Thermal Transient Impedance, Junction-to-Case

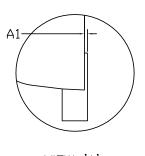


DFN5x6\_8L\_EP1\_P PACKAGE OUTLIN



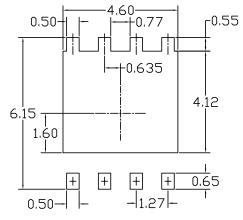






<u>VIEW 'A'</u> (SCALE 5:1)

### RECOMMENDED LAND PATTERN



SYMBOLS DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES				
SYMBOLS	MIN	NOM	MAX	MIN	NOM	MAX	
A	0.85	0. 95	1.00	0.033	0.037	0.039	
A1	0.00		0.05	0.000		0.002	
b	0.30	0.40	0.50	0.012	0.016	0.020	
c	0. 15	0. 20	0. 25	0.006	0.008	0.010	
D	5. 10	5. 20	5. 30	0. 201	0. 205	0. 209	
D1	4. 25	4. 35	4. 45	0. 167	0.171	0. 175	
Е	5. 45	5. 55	5. 65	0. 215	0. 219	0. 222	
E1	5. 95	6.05	6. 15	0. 234	0. 238	0. 242	
E2	3. 525	3.625	3. 725	0.139	0. 143	0. 147	
E3	1. 175	1. 275	1. 375	0.046	0.050	0.054	
e	1. 27 BSC			0. 050 BSC			
L	0.45	0. 55	0.65	0.018	0.022	0.026	
L1	0		0.15	0		0.006	
L2	0.68 REF			0.027 REF			
θ	0°		10°	0°		10°	

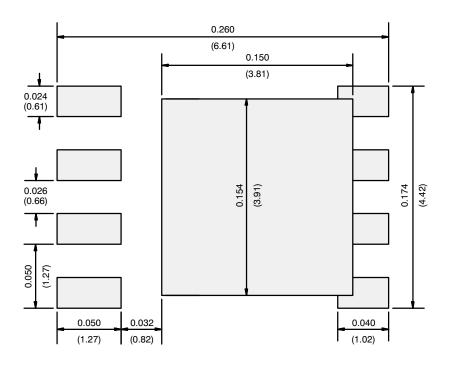
#### NOTE

- 1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.
  MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 2. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.

UNIT: mm



#### **RECOMMENDED MINIMUM PADS FOR DFN5 x 6**



Recommended Minimum Pads Dimensions in Inches/(mm)



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DMN2080UCB4-7 DMN61D9UWQ-13 US6M2GTR DMN31D5UDJ-7 DMP22D4UFO-7B DMN1006UCA6-7 DMN16M9UCA6-7
STF5N65M6 IRF40H233XTMA1 STU5N65M6 DMN6022SSD-13 DMN13M9UCA6-7 DMTH10H4M6SPS-13 DMN2990UFB-7B
IPB80P04P405ATMA2 2N7002W-G MCAC30N06Y-TP MCQ7328-TP BXP7N65D BXP4N65F AOL1454G WMJ80N60C4 BXP2N20L
BXP2N65D BXT1150N10J BXT1700P06M TSM60NB380CP ROG RQ7L055BGTCR DMNH15H110SK3-13 SLF10N65ABV2
BSO203SP BSO211P IPA60R230P6 IPA60R460CE